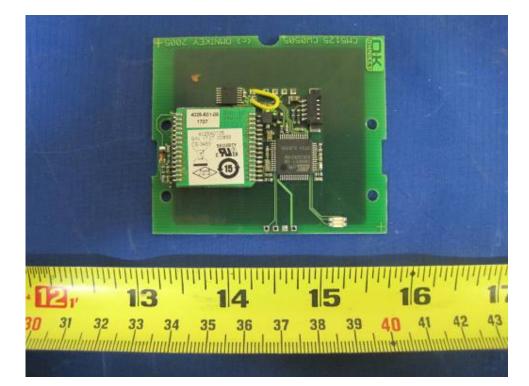
HID GLOBAL CORPORATION

E-CARD 125KHZ RFID RADIO MODULE

Model: OMN5125

15 March 2010 Report No.: SL10020104-HID-003R5-OMN5125(FCC-IC) (This report supersedes None)



To: FCC Part 15.207, 15.209, RSS-GEN, RSS-310 SIEMIC, INC

Modifications made to the product : None

This Test Report is Issued Under the Authority of:	
David Zhang	Buis
David Zhang	Leslie Bai
Test Engineer	Engineering Reviewer

This test report may be reproduced in full only. Test result presented in this test report is applicable to the representative sample only.



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1 Executive Summary & EUT information

The purpose of this test programmed was to demonstrate compliance of the HID Global Corp., Model:OMN5125 against the current Stipulated Standards.

The equipment under test radio operating frequency is 125KHz.

The test has demonstrated that this unit complies with stipulated standards.

	EUT Information						
EUT Description	The OMN5125 is HID product that is E-card 125KHz RFID Module with following specification						
	E-card 125KHz RFID Radio						
	Type : HID Prox						
	Carrier Frequency : 125KHz +/- 0.5%						
	Data Transmission: 112.5KHz&109.375KHz+/- 0.5% subcarrier						
	FSK, 0% depth, 1.25k bits max bit rate						
Model No	: OMN5125						
Serial No	÷ N/A						
Input Power	: 5 VDC						
Classification Per Stipulated Test Standard	: Class B Emission Product						



SIEMIC, INC. Accessing global markets RF Test Report of HID Global Corporation Model : OMN5125 CFR 15.209, RSS 310

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2 TECHNICAL DETAILS

Purpose	Compliance testing of E-card 125KHz RFID Radio Module with stipulated standard
Applicant / Client	HID Global Corporation
Manufacturer	HID Global Corporation 15730 Barranca Parkway Irvine, CA 92618 USA
Laboratory performing the tests	SIEMIC Laboratories
Test report reference number	SL10020104-HID-003R5-OMN5125(FCC-IC)
Date EUT received	01 March 2010
Standard applied	47 CFR §15.207, 15.209, Canadian Standards RS-GEN Issue 2: 2007, RSS- 210 Issue 7: 2007
Dates of test (from – to)	01 March 2010 – 15 March 2010
No of Units:	1
Equipment Category:	DXX
Model :	OMN5125
RF Operating Frequency (ies)	125KHz (RFID)
Number of Channels :	125KHz(1)
FCC ID :	JQ6X001800D
IC ID :	N/A



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3 MODIFICATION

NONE



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4 TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

Class B Emission Product

Test Results Summary

Test	Standard		
47 CFR Part 15 : 2009	RSS 210 Issue 7: 2007 & RSS-310 Issue 2: 2007	Description Pass	
15.203		Antenna Requirement	Pass
15.207(a)	RSS Gen(7.2.2)	Conducted Emissions Voltage	Pass
15.209	RSS210(A2.6)	Radiated Emissions	Pass
	RSS210(A2.6)	Frequency Stability	Pass
	RSS-210(5.9.1)	Occupied Bandwidth	Pass
	RSS-310 (3.7)	Very Low Power Devices Operating Below 490 kHz	Pass
ANSI C63.4: 2003/ RSS-G6	en Issue 2: 2007		

PS: All measurement uncertainties are not taken into consideration for all presented test result.



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5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

5.1 Antenna Requirement

Requirement(s): 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
- b) Antenna must use a unique type of connector to attach to the device.
- c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.
- 1) The RFID antenna is integral to the main board permanently to the device which meets the requirement.



5.2 Conducted Emissions Voltage

Requirement(s): 47 CFR §15.207 & RSS 310

Requirement:

Frequency of emission (MHz)	Conducted limit (dB[mu]V)		
	Quasi-peak Average		
0.15-0.5	66 to 56*	56 to 46*	
0.5-5	56	46	
5-30	60	50	

*Decreases with the logarithm of the frequency.

Procedures:

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
- A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
 Conducted Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz – 30MHz (Average & Quasi-peak) is ±3.5dB.

4.	Environmental Conditions	Temperature	28°C
		Relative Humidity	50%
		Atmospheric Pressure	1019mbar
	Test Date : March 1-15 2010		

Test Date : March 1-15 2010 Tested By : David Zhang

Results: Pass



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Frequency (MHz)	QP Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
1.58	55.63	56.00	Pass	-0.37	43.40	46.00	Pass	-2.60	Phase
1.84	55.45	56.00	Pass	-0.55	43.27	46.00	Pass	-2.73	Phase
1.23	50.62	56.00	Pass	-5.38	40.52	46.00	Pass	-5.48	Phase
2.10	50.59	56.00	Pass	-5.41	42.48	46.00	Pass	-3.52	Phase
1.31	51.36	56.00	Pass	-4.64	42.97	46.00	Pass	-3.03	Phase
1.03	46.44	56.00	Pass	-9.56	38.59	46.00	Pass	-7.41	Phase

1201/ 60Hz Phase Line

120V, 60Hz, Neutral Line

Frequency (MHz)	QP Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Avg Value (dBµV)	Class B Limit (dB)	Pass / Fail	Margin (dB)	Line
1.84	54.22	56.00	Pass	-1.78	43.82	46.00	Pass	-2.18	Neutral
1.69	55.14	56.00	Pass	-0.86	43.53	46.00	Pass	-2.47	Neutral
1.31	47.23	56.00	Pass	-8.77	40.11	46.00	Pass	-5.89	Neutral
1.58	53.25	56.00	Pass	-2.75	45.91	46.00	Pass	-0.09	Neutral
0.84	50.89	56.00	Pass	-5.11	42.39	46.00	Pass	-3.61	Neutral
1.47	50.42	56.00	Pass	-5.58	39.31	46.00	Pass	-6.69	Neutral



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5.3 Radiated Emission < 30MHz (9kHz - 30MHz, H-Field)

Requirement(s): 47 CFR §15.209; RSS-210 (A2.6) & RSS-310 (3.7)

Procedures: For < 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The loop antenna was positioned 1 meter above the ground from the centre of the loop. The measuring bandwidth was set to 10 kHz. (Note: During testing the receive antenna was rotated about its axis to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude (dBµV/m) + ACF (dB) + Cable Loss(dB) – Distance Correction Factor

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- Radiated Emissions Measurement Uncertainty All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, is +/-6dB.
- 4. Environmental Conditions
- Temperature Relative Humidity Atmospheric Pressure

23°C 50% 1019mbar

Test Date : March 1-15 2010 Tested By : David Zhang

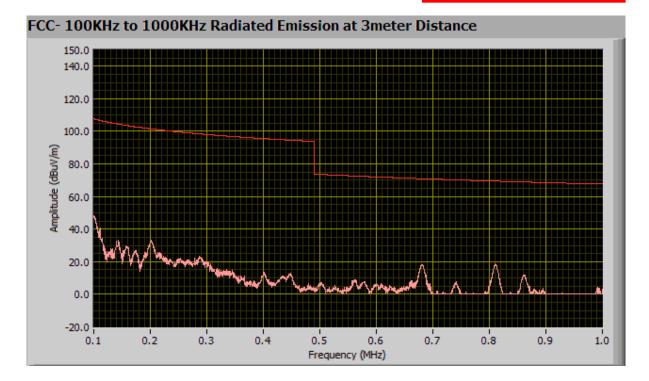
Results: Pass



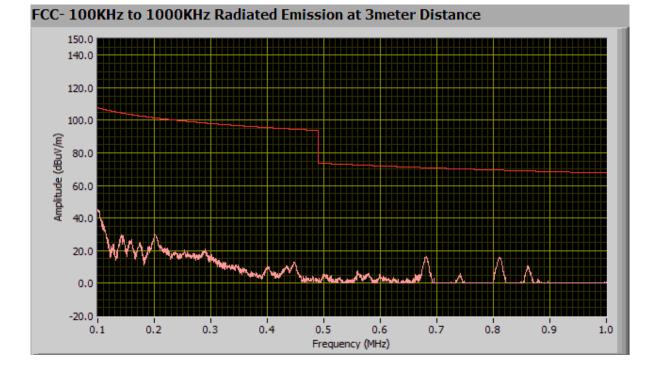
100KHz ~ 1MHz

Dipole Antenna at 0 degree

General Emission Limit @ 3 Meter



Dipole Antenna at 90 degree





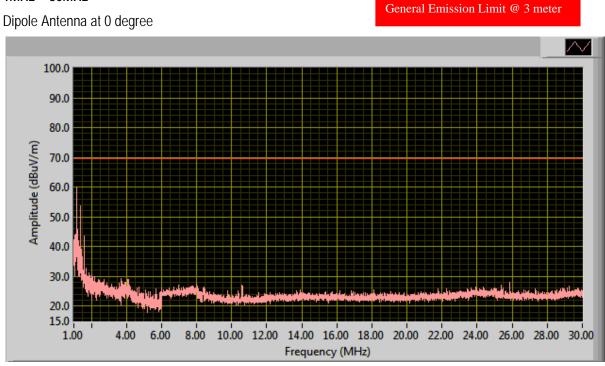
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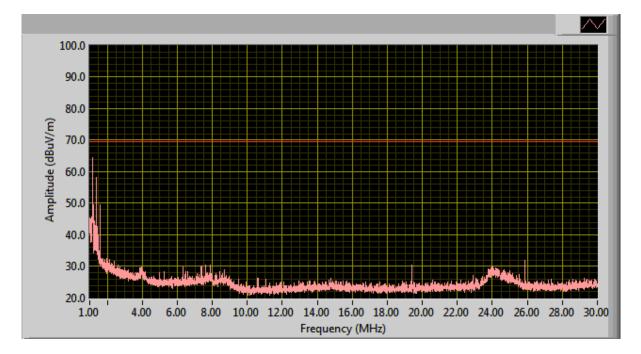
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1MHz ~ 30MHz



Dipole Antenna at 90 degree





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5.4 Radiated Emissions > 30 MHz (30MHz - 1 GHz, E-Field)

Requirement(s): 47 CFR §15.209; RSS-310

Procedures: For > 30MHz, Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output power. The EUT was set 10 meter away from the measuring antenna. The Log periodic antenna was positioned 1 meter above the ground from the centre of the antenna. The measuring bandwidth was set to 120 kHz. (Note: During testing the receive antenna was raise from 1~4 meters to maximize the emission from the EUT.)

The limit is converted from microvolt/meter to decibel microvolt/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude (dBµV/m) + ACF (dB) + Cable Loss(dB) – Distance Correction Factor

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- Radiated Emissions Measurement Uncertainty All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, is +/-6dB.
- 4. Environmental Conditions Temperature 23°C Relative Humidity 50% Atmospheric Pressure 1019mbar Test Date : March 1-15 2010 Tested By : David Zhang

Results: Pass

Radiated Emission Test Table 30MHz ~ 1000MHz

Frequency (MHz)	Amplitude @ 3m	Azimuth (degree)	Antenna Polarity	Antenna Height (cm)	Limit @ 3 meter	margin (dB)
37.91	28.96	145.00	V	110.00	40.00	-11.04
62.54	24.65	2.00	V	120.00	40.00	-15.35
152.01	25.28	330.00	V	109.00	43.50	-18.22
839.99	45.00	191.00	Н	190.00	46.00	-1.00
135.18	22.97	11.00	V	121.00	43.50	-20.53
923.98	45.23	302.00	Н	215.00	46.00	-0.77



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5.5 Frequency Stability

Requirement(s): None

Procedures: Frequency Stability was measured according to 47 CFR §2.1055. Measurement was taken with spectrum analyzer. The spectrum analyzer bandwidth and span was set to read in hertz. A voltmeter was used to monitor when varying the voltage.

Limit: ±0.01% of 13.56 MHz = 1356 Hz, ±0.01% of 125 kHz = 125 Hz

Environmental Conditions	Temperature Relative Humidity	23ºC 50%
	Relative Fluitliuity	5076
	Atmospheric Pressure	1019mbar
Test Date : March 1-15 2010	-	
Tested By : David Zhang		

Results: Pass

Frequency Stability versus Temperature: The Frequency tolerance of the carrier signal shall be maintained within \pm 0.01% of the operating frequency over a temperature variation of -20°C to +50°C at normal supply voltage.

Test Result for E-card 125KHz RFID Module

Reference Frequency: 127.50kHz at -20°C and +50°C

Temperature (°C)	Measured Freq. (KHz)	Freq. Drift (KHz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
50	127.42	-0.08	<0.01	Pass
20		127.50(Reference))	
-20	127.42	-0.08	<0.01	Pass

Note: The EUT met the applicable requirement throughout the temperature range. Only the extremes are reported

Frequency Stability versus Input Voltage: The Frequency tolerance of the carrier signal shall be maintained within ± 0.01%, the frequency of the transmitter was measured at 85% and at 115% of the rated power supply voltage at 20°C environmental temperature.

Carrier Frequency: 127.40kHz at 20°C at 120VAC

Measured Voltage ±15% of nominal (AC)	Measured Freq. (KHz)	Freq. Drift (KHz)	Freq. Deviation (Limit: 0.01%)	Pass/Fail
102	127.54	0.04	<0.01	Pass
138	127.58	0.08	<0.01	Pass



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50%

1019mbar

5.6 Fundamental Field Strength Test Result

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.
- A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
 <u>Radiated Emissions Measurement Uncertainty</u> All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, is +/-6dB.
 Environmental Conditions Temperature 23°C

Relative Humidity Atmospheric Pressure

Test Date : March 1-15 2010 Tested By : David Zhang

Test Requirement :

125KHz ----- The fundamental field strength should not exceed general spurious emission requirement.

Dipole Antenna at 0 degree

Frequency	Measure	Ant. Height	Factor	Amplitude @ 3m	Limits @ 3m	Margin
(MHz)	(Avg/QP)	(m)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	Peak	1.00	64.76	74.76	105.67	-31.21

Dipole Antenna at 90 degree

Frequency	Measure	Ant. Height	Factor	Amplitude @ 3m	Limits @ 3m	Margin
(MHz)	(Avg/QP)	(m)	(dB)	(dBµV/m)	(dBµV/m)	(dBµV/m)
0.125	Peak	1.00	64.76	66.84	105.67	-38.83



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5.7 Occupied Bandwidth

Requirement(s): None

Procedure		neasured according to RSS-210 (5.9.1). nalyzer bandwidth and span was set to r	. Measurement was taken with spectrum read in hertz.
1.		e investigated. Only the 6 worst case em nissions were relatively insignificant.	issions measured, using the correct CISPR
2.		it refers to the margin present below the I	limit line at the particular frequency.
3.		are traceable to national standards. The	uncertainty of the measurement at a normal), with a coverage factor of 2, is +/-
4.	Environmental Conditions	Temperature	23°C
		Relative Humidity	50%
		Atmospheric Pressure	1019mbar
	Test Date : March 1-15 2010		
	Tested By : David Zhang		

Results: Pass

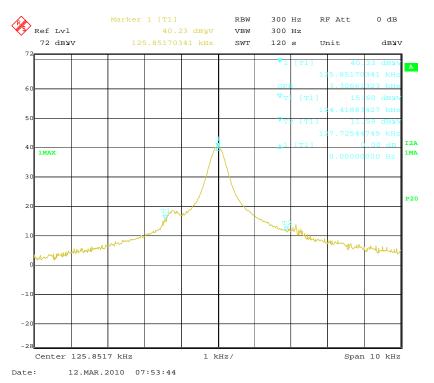
SIEMIC, INC. Accessing global manufes Title: To To CFR 15.209, RSS 310

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Plots: 125 kHz





Annex A. TEST INSTRUMENT & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Instrument	Model	Calibration Date	Calibration Due Date
AC Conducted Emissions			
R&S EMI Test Receiver	ESIB40	04/25/2009	04/25/2010
R&S LISN	ESH2-Z5	04/24/2009	04/24/2010
CHASE LISN	MN2050B	04/24/2009	04/24/2010
Radiated Emissions			
Spectrum Analyzer	8564E	04/26/2009	04/26/2010
EMI Receiver	ESIB 40	4/25/2009	4/25/2010
R&S LISN	ESH2-Z5	04/24/2009	04/24/2010
CHASE LISN	MN2050B	04/24/2009	04/24/2010
Antenna(1 ~18GHz)	3115	10/04/2009	10/04/2010
Antenna (30MHz~2GHz)	JB1	10/04/2009	10/04/2010
Chamber	3m	04/18/2009	04/18/2010
Pre-Amplifier(1 ~ 26GHz)	8449	04/24/2009	04/24/2010
Horn Antenna (18~40GHz)	AH-840	03/19/2009	03/19/2011
Microwave Pre-Amp (18~40GHz)	PA-840	03/19/2009	03/19/2011*
Frequency Tolerance			
Spectrum Analyzer	8564E	04/26/2009	04/26/2010
Temperature/Humidity Chamber	1007H	04/23/2009	04/23/2010



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Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in <u>Annex B</u>.
- 2. The power supply for the EUT was fed through a $50\Omega/50\mu$ H EUT LISN, connected to filtered mains.
- 3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
- 4. All other supporting equipments were powered separately from another main supply.

Test Method

- 1. The EUT was switched on and allowed to warm up to its normal operating condition.
- 2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
- 3. High peaks, relative to the limit line, were then selected.
- 4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 KHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
- 5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Sample Calculation Example

At 20 MHz	limit = 250 μ V = 47.96 dB μ V
Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.2	0 dB
Q-P reading obtained directly from EMI Receiver = 40.00 dB μ V (Calibrated for system losses)	
Therefore, Q-P margin = 47.96 – 40.00 = 7.96	i.e. 7.96 dB below limit



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Annex A. iii RADIATED EMISSIONS TEST DESCRIPTION

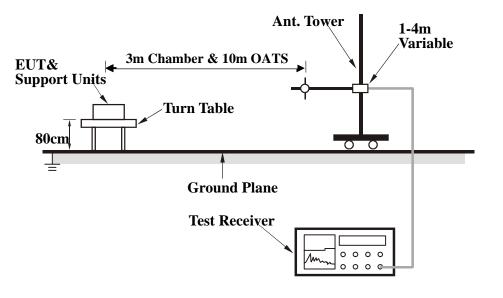
EUT Characterisation

EUT characterisation, over the frequency range from 100kHz – 1GHz to 10th Harmonic, was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred; clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS) at 10m distance.

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m X 1.0m X 0.8m high, non-metallic table.
- 2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
- 3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.





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Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.

2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.

3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.

2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.

3. For emission frequencies measured below 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.

4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from $0 \circ to 360 \circ$ with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.

5. Repeat step 4 until all frequencies need to be measured were complete.

6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	Peak	100 kHz	100 kHz
Above 1000	Peak	1 MHz	1 MHz
	Average	1 MHz	10 Hz

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

Peak = Reading + Corrected Factor

where

Corr. Factor = Antenna Factor + Cable Factor - Amplifier Gain (if any) And the average value is

Average = Peak Value + Duty Factor or Set RBW = 1MHz, VBW = 10Hz.

Note :

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1 GHz. And the measuring instrument is set to quasi peak detector function.



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Annex B. TEST SETUP PHOTOGRAPHS

Please See Attachment



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Annex B. i. EUT INTERNAL PHOTOGRAPHS

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Annex B. ii. EUT EXTERNAL PHOTOGRAPHS

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 WMWN signing com

Annex C. SUPPORTING EQUIPMENT DESCRIPTION

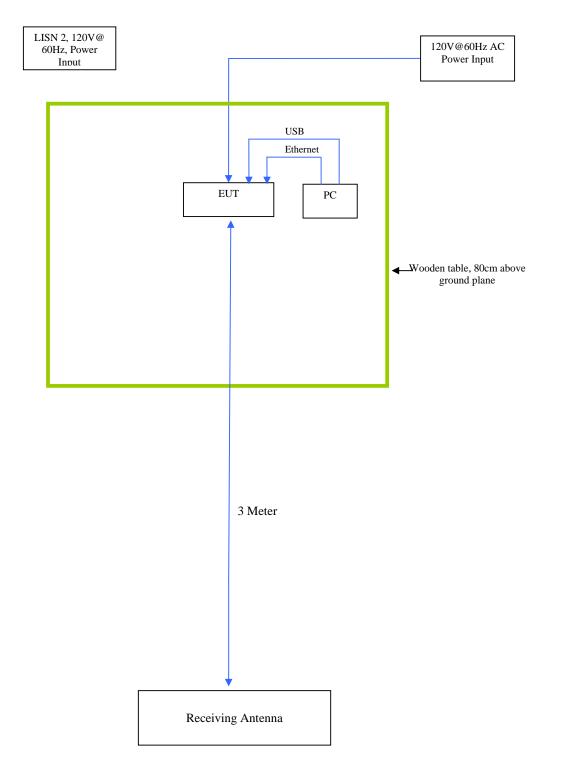
The following is a description of supporting equipment and details of cables used with the EUT.

Equipment Description (Including Brand Name)	Model & Serial Number	Cable Description (List Length, Type & Purpose)
-		-

NOTE: No special supporting equipment are used or needed during testing to achieve compliance.

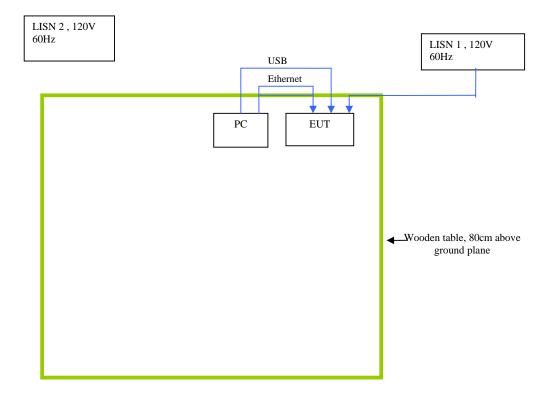


Block Configuration Diagram for Radiated Emission





Block Configuration Diagram for Conducted Emission





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Annex C. EUT OPERATING CONDITIONS

The following is the description of how the EUT is exercised during testing.

Description Of Operation
The EUT was controlled by itself.
The EUT was controlled by itself.



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Annex D USER MANUAL, BLOCK & CIRCUIT DIAGRAM

Please see attachment



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Annex E SIEMIC ACCREDITATION

SIEMIC ACCREDITATION DETAILS: A2LA 17025 & ISO Guide 65 : 2742.01 , 2742.2

THE AMERICAN ASSOCIATION FOR **ac-m**ra LABORATORY ACCREDITATION Mar Aller ACCREDITED LABORATORY A2LA has accredited SIEMIC LABORATORIES San Jose, CA for technical competence in the field of Electrical Testing This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-ILAF Communiqué dated 18 June 2005). nted this 11th day of July 2008 leta In President For the Accreditation Council Certificate Number 2742.01 Valid to September 30, 2010 For the tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation. THE AMERICAN ASSOCIATION FOR LABORATORY ACCREDITATION ACCREDITED PRODUCT CERTIFICATION BODY A2LA has accredited SIEMIC INC. San Jose, CA for technical competence as a Product Certification Body This product certification body is accredited in accordance with the recognized International Standard ISO/IEC Guide 65:1996 General requirements for bodies operating product certification systems. This accreditation demonstrates technical competence for a defined scope and the operation of a quality management system for a Telecommunications Certification Body (TCB) meeting FCC (U.S.), IDA (Singapore) and IC (Canada) requirements. Service Association and a service and a serv Presented this 9th day of January 2009. President For the Accreditation Council Certificate Number: 2742.02 Valid to: September 30, 2010 For the product certification schemes to which this accreditation applies. please refer to the certification body's Scope of Accreditation



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SCOPE OF ACCREDITATION TO ISO/IEC GUIDE 65:1996

SIEMIC INC.

2206 Ringwood Ave. San Jose, CA 95131 Mr. Snell Leong (Authorized Representative) Phone: 408 526 1188 <u>www.siemic.com</u>

PRODUCT CERTIFICATION CONFORMITY ASSESSMENT BODY (CAB)

Valid to: September 30, 2010

Certificate Number: 2742.02

In recognition of the successful completion of the A2LA Certification Body Accreditation Program evaluation, including the US Federal Communications Commission (FCC), Industry Canada (IC) and Singapore (IDA) requirements for the indicated types of product certifications, accreditation is granted to this organization to perform the following product certification schemes:

Economy

Scope

Federal Communication Commission - (FCC)

Unlicensed Radio Frequency Devices	A1, A2, A3, A4
Licensed Radio Frequency Devices	B1, B2, B3, B4
Telephone Terminal Equipment	С

*Please refer to FCC TCB Program Roles and Responsibilities, v04, released February 14, 2008 detailing scopes, roles and responsibilities. <u>http://www.fcc.gov/oet/ea/FCC-Overview-TCB-Program.pdf</u>

Industry Canada - (IC)

Radio

All Radio Standards Specifications (RSS) in Category I Equipment Standards List Radio

*Please refer to Industry Canada (IC) website at: http://www.ic.gc.ca/epic/site/smt-gst.nsf/en/h_sf01342e.html

IDA – Singapore

Line Terminal Equipment	All Technical Specifications for Line Terminal Equipment – Table 1 of IDA MRA Recognition Scheme: 2008, Annex 2
Radio-Communication Equipment	All Technical Specifications for Radio-Communication Equipment – Table 2 of IDA MRA Recognition Scheme: 2008, Annex 2

*Please refer to Info-Communication Development Authority (iDA) Singapore website at: <u>http://www.ida.gov.sg/doc/Policies%20and%20Regulation/Policies_and_Regulation_Level2/20060609145118/MRA</u> <u>RecScheme.pdf</u>

(A2LA Cert. No. 2742.02) 01/09/09

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SIEMIC ACCREDITATION DETAILS: FCC Test Site Registration No. 783147

FEDERAL COMMUNICATIONS COMMISSION

Laboratory Division 7435 Oakland Mills Road Columbia, MD 21046

December 20, 2007

Registration Number: 783147

SIEMIC Laboratories 2206 Ringwood Avenue, San Jose, CA 95131

Attention: Leslie Bai

Re: Measurement facility located at San Jose 3 & 10 meter site Date of Renewal: December 20, 2007

Dear Sir or Madam:

Your request for renewal of the registration of the subject measurement facility has been received. The information submitted has been placed in your file and the registration has been renewed. The name of your organization will remain on the list of facilities whose measurement data will be accepted in conjunction with applications for Certification under Parts 15 or 18 of the Commission's Rules. Please note that the file must be updated for any changes made to the facility and the registration must be renewed at least every three years.

Measurement facilities that have indicated that they are available to the public to perform measurement services on a fee basis may be found on the FCC website <u>www.fcc.gov</u> under E-Filing, OET Equipment Authorization Electronic Filing, Test Firms.

Sincerely,

Phyllis Parrish Industry Analyst



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SIEMIC ACCREDITATION DETAILS: Industry of Canada CAB ID : US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

March 4, 2009

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by Industry Canada (IC), under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:	SIEMIC, Inc.
Physical Location:	2206 Ringwood Avenue, San Jose, CA 95131 USA
Identification No .:	US0160
Recognized Scope:	CS-03 Part I, II, V, VI, VII and VIII

You may submit test data to IC to verify that the equipment to be imported into Canada satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. Please contact Ms. Ramona Saar at (301) 975-5521 or <u>ramona.saar@nist.gov</u> if you have any questions.

Sincerely,

Parial In Alda

David F. Alderman Group Leader, Standards Coordination and Conformity Group Standards Services Division

Enclosure

cc: CAB Program Manager





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SIEMIC ACCREDITATION DETAILS: Industry of Canada Test Site Registration No. 4842-1

Industry Industrie Canada Canada

May 23rd, 2008

OUR FILE: 46405-4842 Submission No: 126429

Siemic Inc. 2206 Ringwood Ave. San Jose CA 95131 USA

Attention: Leslie Bai

Dear Sir/Madame:

The Bureau has received your application for the registration / renewal of a 3/10m OATS. Be advised that the information received was satisfactory to Industry Canada. The following number(s) is now associated to the site(s) for which registration / renewal was sought (4842A-1). Please reference the appropriate site number in the body of test reports containing measurements performed on the site. In addition, please be informed that the Bureau is now utilizing a new site number of secondary codes associated to one particular company. The following changes have been made to your record.

- Your primary code is: 4842

- The company number associated to the site(s) located at the above address is: 4842A

- The table below is a summary of the changes made to the unique site registration number(s):

New Site	Obsolete Site	Description of Site	Expiry Date
Number	Number		(YYYY-MM-DD)
4842A-1	4842-1	3m Chamber	2010-05-23

Furthermore, to obtain or renew a unique site number, the applicant shall demonstrate that the site has been accredited to ANSI C63.4-2003 or later. A scope of accreditation indicating the accreditation by a recognized accreditation body to ANSI C63.4-2003 shall be accepted. Please indicate in a letter the previous assigned site number if applicable and the type of site (example: 3 meter OATS or 3 meter chamber). If the test facility is not accredited to ANSI C63.4-2003 or later, the test facility shall submit test data demonstrating full compliance with the ANSI standard. The Bureau will evaluate the filing to determine if recognition shall be granted.

The frequency for re-validation of the test site and the information that is required to be filed or retained by the testing party shall comply with the requirements established by the accrediting organization. However, in all cases, test site re-validation shall occur on an interval not to exceed two years. There is no fee or form associated with an OATS filing. OATS submissions are encouraged to be submitted electronically to the Bureau using the following URL; http://strategis.ic.gc.ca/epic/internet/inceb-bhst.nsf/en/h_tt00052e.html.

If you have any questions, you may contact the Bureau by e-mail at <u>certification.bureau@ie.gc.e</u> Please reference our file and submission number above for all correspondence.

Yours sincerely,

56,70

S. Proulx Test & Measurement Specialist Certification and Engineering Bureau 3701 Carling Ave., Building 94 Ottawa, Ontario K2H 8S2



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SIEMIC ACCREDITATION DETAILS: FCC DOC CAB Recognition : US1109

FEDERAL COMMUNICATIONS COMMISSION

Laboratory Division 7435 Oakland Mills Road Columbia, MD 21046

August 28, 2008

Siemic Laboratories 2206 Ringwood Ave., San Jose, CA 95131

Attention: Leslie Bai

Re: Accreditation of Siemic Laboratories Designation Number: US1109 Test Firm Registration #: 540430

Dear Sir or Madam:

We have been notified by American Association for Laboratory Accreditation that Siemic Laboratories has been accredited as a Conformity Assessment Body (CAB).

At this time Siemic Laboratories is hereby designated to perform compliance testing on equipment subject to Declaration Of Conformity (DOC) and Certification under Parts 15 and 18 of the Commission's Rules.

This designation will expire upon expiration of the accreditation or notification of withdrawal of designation.

Sincerely,

George Tannahill

Electronics Engineer



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SIEMIC ACCREDITATION DETAILS: Australia CAB ID : US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

November 20, 2008

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the Australian Communications and Media Authority (ACMA) under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:	Siemic, Inc.
Physical Location:	2206 Ringwood Avenue, San Jose, CA 95131
Identification No.:	US0160
Recognized Scope:	EMC: AS/NZS 4251.1 (until 5/31/2009), AS/NZS 4251.2 (until 5/31/2009),
	AS/NZS CISPR 11, AS/NZS CISPR 14.1, AS/NZS CISPR 22, AS/NZS
	61000.6.3, AS/NZS 61000.6.4
	Radiocommunications: AS/NZS 4281, AS/NZS 4268, AS/NZS 4280.1, AS/NZS
	4280.2, AS/NZS 4295, AS/NZS 4582, AS/NZS 4583, AS/NZS 4769.1, AS/NZS
	4769.2, AS/NZS 4770, AS/NZS 4771
	Telecommunications: AS/ACIF S002:05, AS/ACIF S003:06, AS/ACIF S004:06,
	AS/ACIF S006:01, AS/ACIF S016:01, AS/ACIF S031:01, AS/ACIF S038:01,
	AS/ACIF S040:01, AS/ACIF S041:05, AS/ACIF S043.2:06, AS/NZS 60950.1

You may submit test data to ACMA to verify that the equipment to be imported into Australia satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements. Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. Please contact Ms. Ramona Saar, at (301) 975-5521 or ramona.saar@nist.gov if you have questions.

Sincerely,

Daniel I. alder

David F. Alderman Group Leader, Standards Coordination and Conformity Group Standards Services Division

Enclosure

cc: Snell Leong, Siemic, Inc.; Ramona Saar, NIST





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SIEMIC ACCREDITATION DETAILS: Korea CAB ID: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899

October 1, 2008

Τo

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the Radio Research Agency (RRA) Korea Communications Commission (KCC) under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name: Physical Location: Identification No.: Recognized Scope: SIEMIC, Inc.
2206 Ringwood Avenue, San Jose, CA 95131
US0160
EMI: KCC Notice 2008-39, RRL Notice 2008-3: CA Procedures for EMI KN22: Test Method for EMI
EMS: KCC Notice 2008-38, RRL Notice 2008-4: CA Procedures for EMS KN24, KN-61000-4-2, -4-3, -4-4, -4-5, -4-6, -4-8, -4-11: Test Method for EMS Wireless: RRL Notice 2008-26, RRL Notice 2008-2, RRL Notice 2008-10, RRL Notice 2007-49, RRL Notice 2007-20, RRL Notice 2007-21, RRL Notice 2007-80, RRL Notice 2004-68
Wired: President Notice 20664, RRL Notice 2007-30, RRL Notice 2008-7 with attachments 1, 3, 5, 6
President Notice 20664, RRL Notice 2008-7 with attachment 4

You may submit test data to RRA/KCC to verify that the equipment to be imported into Korea satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely,

Paris In alde

David F. Alderman Group Leader, Standards Coordination and Conformity Group Standards Services Division

Enclosure



cc: Ramona Saar



То

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SIEMIC ACCREDITATION DETAILS: Taiwan BSMI Accreditation No. SL2-IN-E-1130R



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gethersburg, Maryland 20899-

NIC

May 3, 2006

Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai;

I am pleased to inform you that your laboratory has been recognized by the Chinese Taipei's Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. You may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable requirements. The designated scope remains valid and comply with the designation requirements. The pertinent designation information is as follows:

BSMI number:

SL2-IN-E-1130R (Must be applied to the test reports)

U.S Identification No:

US0160 CNS 13438

- Scope of Designation: Authorized signatory:
 - atory: Mr. Leslie Bai

The names of all recognized CABs will be posted on the NIST website at http://ts.nist.gov/mra. If you have any questions, please contact Mr. Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

Part & acces

David F. Alderman Group Leader, Standards Coordination and Conformity Group

ee: Jogindar Dhillon



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SIEMIC ACCREDITATION DETAILS: Taiwan NCC CAB ID: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

November 25, 2008

Mr. LeslieBai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the National Communications Commission (NCC) for the requested scope expansion under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:SIEMIC, Inc.Physical Location:2206 Ringwood Avenue, San Jose, CA 95131Identification No.:US0160Current Scope:LP0002Additional Scope:PSTN01, ADSL01, ID0002, IS6100 and CNS 14336

You may submit test data to NCC to verify that the equipment to be imported into China satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely,

Parid Z. alden

David F. Alderman Group Leader, Standards Coordination and Conformity Group Standards Services Division

Enclosure

cc: Ramona Saar





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SIEMIC ACCREDITATION DETAILS: Mexico NOM Recognition

Laboratorio Valentín V. Rivero VIETI CAMARA NACIONAL BE LA INDUSTRIA ELECTRONICA, DE ECOMUNICACIONES E INFORMATICA México D.F. a 16 de octubre de 2006. LESLIE BAI DIRECTOR OF CERTIFICATION SIEMIC LABORATORIES, INC. ACCESSING GLOBAL MARKETS PRESENTE En contestación a su escrito de fecha 5 de septiembre del año en curso, le comento que estamos muy interesados en su intención de firmar un Acuerdo de Reconocimiento Mutuo, para lo cual adjunto a este escrito encontrara el Acuardo en idioma ingles y español pretenado de los cuales le pido sea revisado y en su caso corregido, para que si esta de acuerdo poder firmarlo para mandarlo con las autoridades Mexicanas para su visto bueno y así poder ejercer dicho acuerdo. Aprovecho este escrito para mencionarle que nuestro intermediario gestor será la empresa Isatel de México. S. A. de C. V., empresa que ha colaborado durante mucho tiempo con nosotros en lo relacionado a la evaluación de la conformidad y que cuenta con amplia experiencia en la gestoria de la certificación de cumplimiento con Normas Oficiales Mexicanas de producto en México. Me despido de ustad enviándole un cordial seludo y esperando sus comentarios al Acuerdo que nos ocupa. Atentamente: Ing. Faustino-Bornez González Gerente-Teenico del Laboratorio de CANTER Collardo T Haddorene Contesa Celto Maxim, D.F. Nel 5204-0038 con 12 intes Fax 5264-0498



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SIEMIC ACCREDITATION DETAILS: Hong Kong OFTA CAB ID : US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

December 8, 2008

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the Office of the Telecommunications Authority (OFTA) under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:	SIEMIC, Inc.
Physical Location:	2206 Ringwood Avenue, San Jose, California 95131 USA
Identification No .:	US0160
Recognized Scope:	Radio: HKTA 1002, 1007, 1008, 1010, 1015, 1016, 1020, 1022, 1026,
	1027, 1029, 1030, 1031, 1032, 1033, 1034, 1035, 1036, 1037, 1039, 1041,
	1042, 1043, 1044, 1046, 1047, 1048, 1049, 1051
	Telecom: HKTA 2011, 2012, 2013, 2014, 2017, 2018, 2022, 2024, 2026,
	2027, 2028, 2029, 2030, 2031, 2032, 2033

You may submit test data to OFTA to verify that the equipment to be imported into Hong Kong satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely,

David I. alden

David F. Alderman Group Leader, Standards Coordination and Conformity Group Standards Services Division

Enclosure

cc: Ramona Saar





Title:

То

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SIEMIC ACCREDITATION DETAILS: VCCI Radiated Test Site Registration No. R-3083





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SIEMIC ACCREDITATION DETAILS: VCCI Conducted (Main Port) Test Site Registration No. C-3421





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SIEMIC ACCREDITATION DETAILS: VCCI Conducted (Telecom Port) Test Site Registration No. T-1597

